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Synthesis and characterization of La₂NiO₄₋₆ coatings deposited by reactive magnetron sputtering using plasma emission monitoringJ r mie FONDARD¹, Alain BILLARD¹, Pascal BRIOIS¹, Ghislaine BERTRAND¹¹LERMPS, UTBM, Belfort, France

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Rare-earth nickelates with K₂NiF₄-type structure, namely Ln₂NiO₄₋₆ (Ln= La, Pr, Nd) are assumed to be promising cathode materials for Intermediate Temperature- Solid Oxide Fuel Cell (IT-SOFC). Such materials exhibit both high mixed ionic-electronic conductivity (MIEC) properties and high catalytic activity. Their thermal expansion coefficient (TEC) is very close to that of electrolyte materials (13 x10⁻⁶ K⁻¹, 11.9 x10⁻⁶ K⁻¹ and 11.6 x10⁻⁶ K⁻¹ for La₂NiO₄, CGO and YSZ respectively). Using MIEC material allows transforming the common triple-phase boundary cathode into a double contact (solid conductor/gas phase) and lowering the cathode polarization. Therefore, the deposition of a dense cathode layer providing a fine microstructure with high electrochemical properties may be manufactured by reactive magnetron sputtering.

La₂NiO₄₋₆ coatings were co-sputtered by reactive magnetron sputtering on different substrates from metallic La and Ni targets in the presence of a reactive argon-oxygen gas mixture. The reactor is a 100-litre sputtering chamber pumped down via a turbo molecular pump allowing base vacuum of about 10⁻⁴ Pa. The deposition stage is controlled by Plasma Emission Monitoring (PEM) which consists in monitoring the reactive gas flow in order to maintain constant the optical emission of a metallic species (in this case La), which is proportional to the sputtered metal flow. Once determined the composition to synthesize stoichiometric La₂O₃, the discharge current on the nickel target is adjusted to obtain the convenient composition for lanthanum nickelate. Whatever their composition, the as-deposited coatings are amorphous, and crystallize under K₂NiF₄ structure with appropriate annealing temperature. The structural and chemical features of these coatings have been determined by X-Ray Diffraction and Scanning Electron Microscopy. Their electrical properties were evaluated using four points probe method and Electrochemical Impedance Spectroscopy (EIS).

Keywords

lanthanum nickelate
mixed ionic-electronic conductivity
reactive magnetron sputtering
plasma emission monitoring
electrical properties